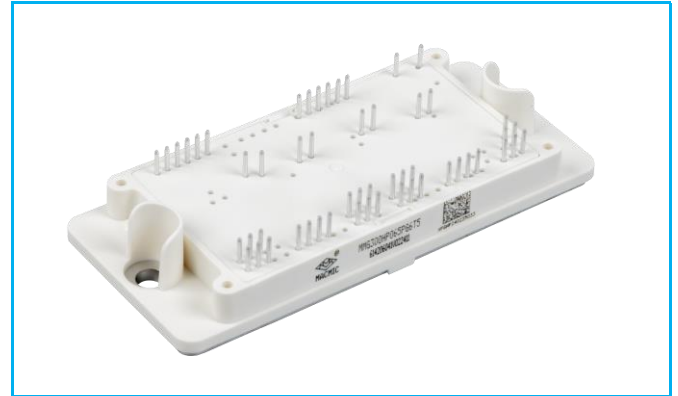


PRODUCT FEATURES

- High efficient and compact symmetric booster
- High switching frequency and low inductive design
- Low losses with TRENCHSTOP™ 5 IGBT
- Integrated temperature sensor



APPLICATIONS

- UPS Systems

Module Characteristics ($T_c=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions		Values	Unit
T_{Jop}	Operating Temperature		-40~150	°C
T_{stg}	Storage Temperature		-40~125	
V_{isol}	Isolation Breakdown Voltage	AC, 50Hz(R.M.S), t=1minute	2500	V
Creepage distance			min. 12.7	mm
Clearance			10.43	mm
CTI	Comparative Tracking Index		> 600	
Md	Mounting Torque	Recommended (M5)	1.3~1.5	Nm
Weight			176	g

MacMic Science & Technology Co., Ltd.

Add: #18, Hua Shan Zhong Lu, New District, Changzhou City, Jiangsu Province, P. R .of China

Tel.: +86-519-85163708 Fax: +86-519-85162291 Post Code: 213022 Website: www.macmicst.com

MMG300HP065PG6T5

Absolute Maximum Ratings ($T_C=25^\circ\text{C}$ unless otherwise specified)

IGBT(T11、T12、T13、T14)

Symbol	Parameter/Test Conditions		Values	Unit
V_{CES}	Collector Emitter Voltage	$T_{vj}=25^\circ\text{C}$	650	V
V_{GES}	Gate Emitter Voltage		± 20	
I_C	DC Collector Current	$T_C=25^\circ\text{C}, T_{vjmax}=175^\circ\text{C}$	345	A
I_{Cpulse}	Pulsed Collector Current	tp limited by T_{vjmax}	900	
P_{tot}	Power Dissipation	$T_C=25^\circ\text{C}, T_{vjmax}=175^\circ\text{C}$	600	W
T_{vjmax}	Max. Virtual Junction Temperature		175	$^\circ\text{C}$

SIC(D11、D12)

Symbol	Parameter/Test Conditions		Values	Unit
V_{RRM}	Repetitive Reverse Voltage	$T_{vj}=25^\circ\text{C}$	650	V
I_F	Continue Forward Current		200	A
I_{FRM}	Repetitive Peak Forward Current	tp limited by T_{vjmax}	800	
T_{vjmax}	Max. Virtual Junction Temperature		175	$^\circ\text{C}$

FRED(D14、D15)

Symbol	Parameter/Test Conditions		Values	Unit
V_{RRM}	Repetitive Reverse Voltage	$T_{vj}=25^\circ\text{C}$	1200	V
I_F	Continue Forward Current		300	A
I_{FRM}	Repetitive Peak Forward Current	tp limited by T_{vjmax}	600	
T_{vjmax}	Max. Virtual Junction Temperature		175	$^\circ\text{C}$

FRED(D41、D42、D43、D44)

Symbol	Parameter/Test Conditions		Values	Unit
V_{RRM}	Repetitive Reverse Voltage	$T_{vj}=25^\circ\text{C}$	650	V
I_F	Continue Forward Current		30	A
I_{FRM}	Repetitive Peak Forward Current	tp limited by T_{vjmax}	60	
T_{vjmax}	Max. Virtual Junction Temperature		175	$^\circ\text{C}$

MMG300HP065PG6T5

Electrical Characteristics ($T_C=25^\circ\text{C}$ unless otherwise specified)

IGBT(T11、T12)

Symbol	Parameter/Test Conditions		Min.	Typ.	Max.	Unit
$V_{GE(th)}$	Gate Emitter Threshold Voltage	$V_{CE}=V_{GE}, I_C=3\text{mA}$	3.2	4.0	4.8	V
$V_{CE(sat)}$	Collector Emitter Saturation Voltage	$I_C=300\text{A}, V_{GE}=15\text{V}, T_{vj}=25^\circ\text{C}$		1.40		
		$I_C=300\text{A}, V_{GE}=15\text{V}, T_{vj}=125^\circ\text{C}$		1.51		
		$I_C=300\text{A}, V_{GE}=15\text{V}, T_{vj}=150^\circ\text{C}$		1.55		
I_{CES}	Collector Leakage Current	$V_{CE}=650\text{V}, V_{GE}=0\text{V}, T_{vj}=25^\circ\text{C}$			100	μA
I_{GES}	Gate Leakage Current	$V_{CE}=0\text{V}, V_{GE}=\pm 20\text{V}, T_{vj}=25^\circ\text{C}$	-400		400	nA
R_{Gint}	Integrated Gate Resistor			0.5		Ω
Q_G	Gate Charge	$V_{CE}=350\text{V}, I_C=300\text{A}, V_{GE}=15\text{V}$		0.61		μC
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}, V_{GE}=0\text{V}, f=1\text{MHz}$		22		nF
C_{oes}	Output Capacitance			630		pF
C_{res}	Reverse Transfer Capacitance			110		pF
$t_{d(on)}$	Turn on Delay Time	$V_{CC}=350\text{V}, I_C=300\text{A}$ $R_{Gon}=5\Omega,$ $R_{Goff}=20\Omega,$ $V_{GE}=\pm 15\text{V},$ Inductive Load	$T_{vj}=25^\circ\text{C}$		65	ns
			$T_{vj}=125^\circ\text{C}$		60	ns
			$T_{vj}=150^\circ\text{C}$		60	ns
t_r	Rise Time		$T_{vj}=25^\circ\text{C}$		53	ns
			$T_{vj}=125^\circ\text{C}$		58	ns
			$T_{vj}=150^\circ\text{C}$		60	ns
$t_{d(off)}$	Turn off Delay Time	$T_{vj}=25^\circ\text{C}$		495	ns	
		$T_{vj}=125^\circ\text{C}$		530	ns	
		$T_{vj}=150^\circ\text{C}$		540	ns	
t_f	Fall Time	$T_{vj}=25^\circ\text{C}$		62	ns	
		$T_{vj}=125^\circ\text{C}$		80	ns	
		$T_{vj}=150^\circ\text{C}$		86	ns	
E_{on}	Turn on Energy	$T_{vj}=25^\circ\text{C}$		1.75	mJ	
		$T_{vj}=125^\circ\text{C}$		2.30	mJ	
		$T_{vj}=150^\circ\text{C}$		2.50	mJ	
E_{off}	Turn off Energy	$T_{vj}=25^\circ\text{C}$		8.40	mJ	
		$T_{vj}=125^\circ\text{C}$		8.70	mJ	
		$T_{vj}=150^\circ\text{C}$		8.90	mJ	
R_{thJC}	Junction to Case Thermal Resistance				0.25	K/W

Collector Emitter Voltage

Electrical Characteristics ($T_C=25^\circ\text{C}$ unless otherwise specified)

IGBT(T13、T14)

Symbol	Parameter/Test Conditions		Min.	Typ.	Max.	Unit
$V_{GE(th)}$	Gate Emitter Threshold Voltage	$V_{CE}=V_{GE}, I_C=3\text{mA}$	3.2	4.0	4.8	V
$V_{CE(sat)}$	Collector Emitter Saturation Voltage	$I_C=300\text{A}, V_{GE}=15\text{V}, T_{vj}=25^\circ\text{C}$		1.40		
		$I_C=300\text{A}, V_{GE}=15\text{V}, T_{vj}=125^\circ\text{C}$		1.51		
		$I_C=300\text{A}, V_{GE}=15\text{V}, T_{vj}=150^\circ\text{C}$		1.55		
I_{CES}	Collector Leakage Current	$V_{CE}=650\text{V}, V_{GE}=0\text{V}, T_{vj}=25^\circ\text{C}$			100	μA
I_{GES}	Gate Leakage Current	$V_{CE}=0\text{V}, V_{GE}=\pm 20\text{V}, T_{vj}=25^\circ\text{C}$	-400		400	nA
R_{Gint}	Integrated Gate Resistor			0.5		Ω
Q_G	Gate Charge	$V_{CE}=350\text{V}, I_C=300\text{A}, V_{GE}=15\text{V}$		0.61		μC
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}, V_{GE}=0\text{V}, f=1\text{MHz}$		22		nF
C_{oes}	Output Capacitance			630		pF
C_{res}	Reverse Transfer Capacitance			110		pF
$t_{d(on)}$	Turn on Delay Time	$V_{CC}=350\text{V}, I_C=300\text{A}$ $R_{Gon}=5\Omega,$ $R_{Goff}=20\Omega,$ $V_{GE}=\pm 15\text{V},$ Inductive Load	$T_{vj}=25^\circ\text{C}$		64	ns
			$T_{vj}=125^\circ\text{C}$		60	ns
			$T_{vj}=150^\circ\text{C}$		58	ns
t_r	Rise Time		$T_{vj}=25^\circ\text{C}$		53	ns
			$T_{vj}=125^\circ\text{C}$		60	ns
			$T_{vj}=150^\circ\text{C}$		62	ns
$t_{d(off)}$	Turn off Delay Time	$T_{vj}=25^\circ\text{C}$		510	ns	
		$T_{vj}=125^\circ\text{C}$		530	ns	
		$T_{vj}=150^\circ\text{C}$		540	ns	
t_f	Fall Time	$T_{vj}=25^\circ\text{C}$		62	ns	
		$T_{vj}=125^\circ\text{C}$		80	ns	
		$T_{vj}=150^\circ\text{C}$		84	ns	
E_{on}	Turn on Energy	$T_{vj}=25^\circ\text{C}$		2.63	mJ	
		$T_{vj}=125^\circ\text{C}$		5.00	mJ	
		$T_{vj}=150^\circ\text{C}$		5.50	mJ	
E_{off}	Turn off Energy	$T_{vj}=25^\circ\text{C}$		8.50	mJ	
		$T_{vj}=125^\circ\text{C}$		9.30	mJ	
		$T_{vj}=150^\circ\text{C}$		9.60	mJ	
R_{thJC}	Junction to Case Thermal Resistance				0.25	K/W

MMG300HP065PG6T5

SIC(D11、D12)

Symbol	Parameter/Test Conditions	Min.	Typ.	Max.	Unit	
V _F	Forward Voltage	I _F =200A , V _{GE} =0V, T _{vj} =25°C		1.46	1.75	V
		I _F =200A , V _{GE} =0V, T _{vj} =125°C		1.65		
		I _F =200A , V _{GE} =0V, T _{vj} =150°C		1.7		
R _{thJC}	Junction to Case Thermal Resistance			0.45	K /W	

FRED(D14、D15)

Symbol	Parameter/Test Conditions	Min.	Typ.	Max.	Unit	
V _F	Forward Voltage	I _F =300A , V _{GE} =0V, T _{vj} =25°C		1.8	2.3	V
		I _F =300A , V _{GE} =0V, T _{vj} =125°C		1.55		
		I _F =300A , V _{GE} =0V, T _{vj} =150°C		1.45		
t _{rr}	Reverse Recovery Time	I _F =300A , V _R =350V T _{vj} =25°C, di _F /dt=-5900A/μs;	T _{vj} =25°C	110		ns
			T _{vj} =125°C	180		ns
			T _{vj} =150°C	200		ns
I _{RRM}	Max. Reverse Recovery Current	T _{vj} =125°C, di _F /dt=-5300A/μs;	T _{vj} =25°C	235		A
			T _{vj} =125°C	340		A
			T _{vj} =150°C	386		A
Q _{RR}	Reverse Recovery Charge	T _{vj} =150°C, di _F /dt=-5000A/μs;	T _{vj} =25°C	12.7		μC
			T _{vj} =125°C	29.6		μC
			T _{vj} =150°C	37.8		μC
E _{rec}	Reverse Recovery Energy		T _{vj} =25°C	7.3		mJ
			T _{vj} =125°C	16.6		mJ
			T _{vj} =150°C	18.3		mJ
R _{thJC}	Junction to Case Thermal Resistance			0.153	K /W	

MMG300HP065PG6T5

FRED(D41、D42、D43、D44)

Symbol	Parameter/Test Conditions	Min.	Typ.	Max.	Unit	
V_F	Forward Voltage	$I_F=30A, V_{GE}=0V, T_{vj}=25^\circ C$		1.8	2.3	V
		$I_F=30A, V_{GE}=0V, T_{vj}=125^\circ C$		1.55		
		$I_F=30A, V_{GE}=0V, T_{vj}=150^\circ C$		1.45		
R_{thJC}	Junction to Case Thermal Resistance			2.2	K /W	

NTC Characteristics ($T_C=25^\circ C$ unless otherwise specified)

Symbol	Parameter/Test Conditions	Min.	Typ.	Max.	Unit
R_{25}	Resistance $T_C=25^\circ C$		22		k Ω
$\Delta R/R$	$T_{NTC}=100^\circ C, R_{100}=1.486k\Omega$	-5		5	%
$B_{25/50}$	$R_2 = R_{25} \exp [B_{25/50}(1/T_2 - 1/(298.15 K))]$		3950		K

MMG300HP065PG6T5

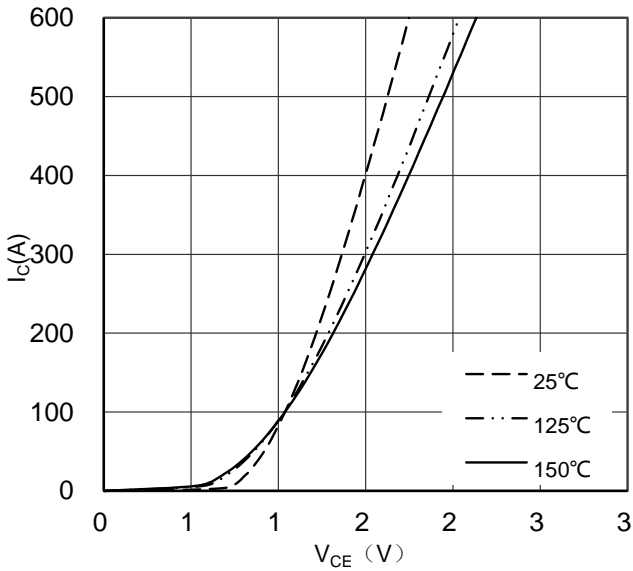


Figure 1. Typical Output Characteristics IGBT (T11, T12, T13, T14)

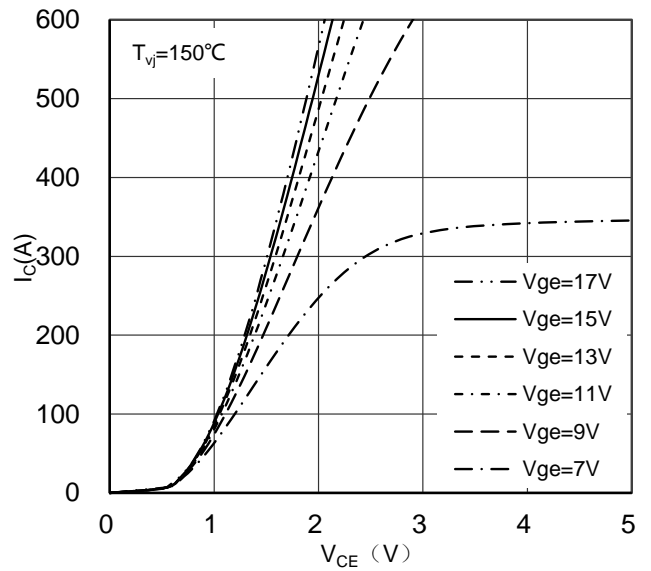


Figure 2. Typical Output Characteristics IGBT (T11, T12, T13, T14)

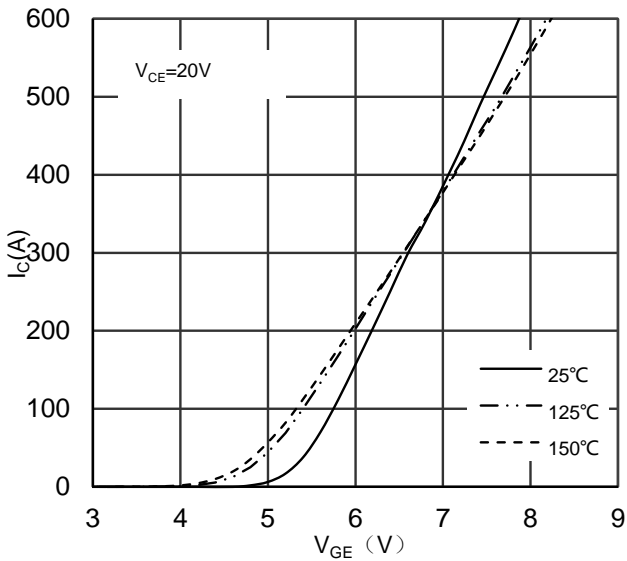


Figure 3. Typical Transfer characteristics IGBT (T11, T12, T13, T14)

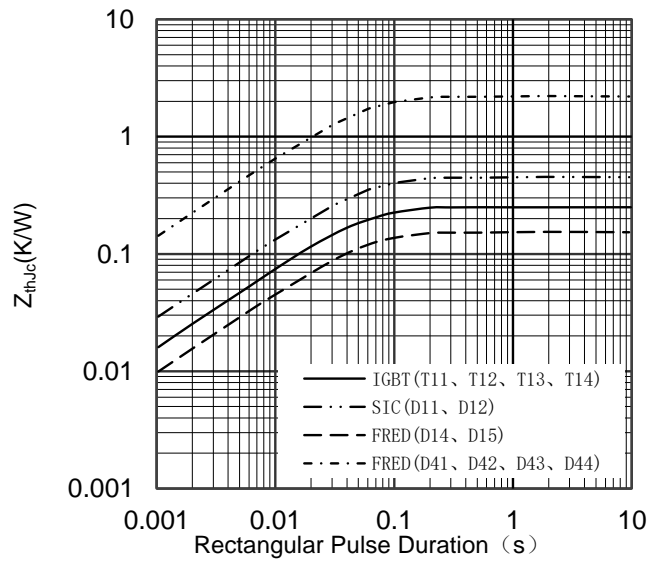


Figure 4. Transient Thermal Impedance

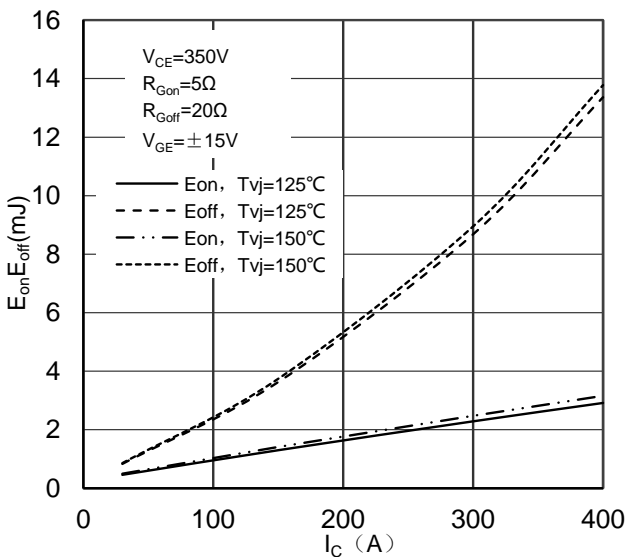


Figure 5. Switching Energy vs Collector Current IGBT (T11, T12)

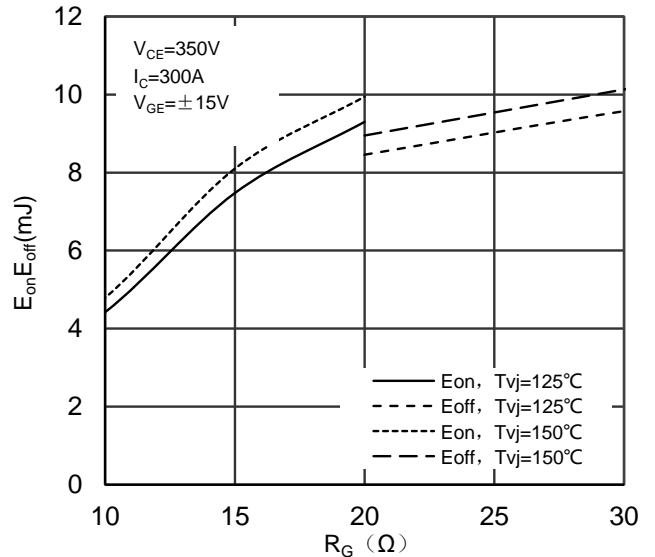


Figure 6. Switching Energy vs Gate Resistor IGBT (T11, T12)

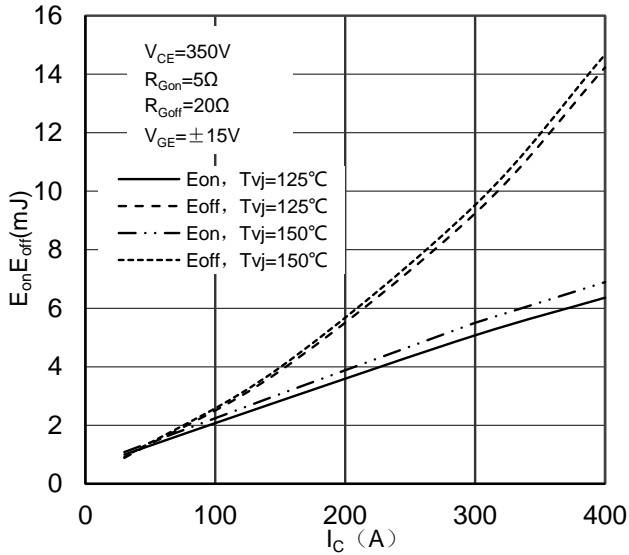


Figure 7. Switching Energy vs Collector Current IGBT (T13, T14)

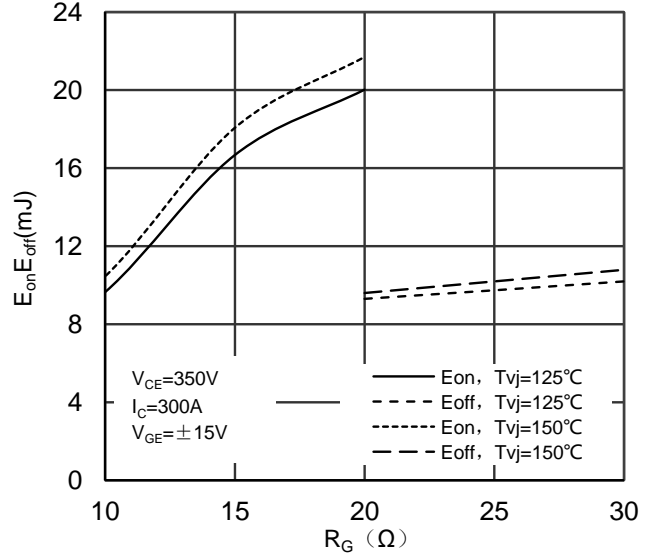


Figure 8. Switching Energy vs Gate Resistor IGBT (T13, T14)

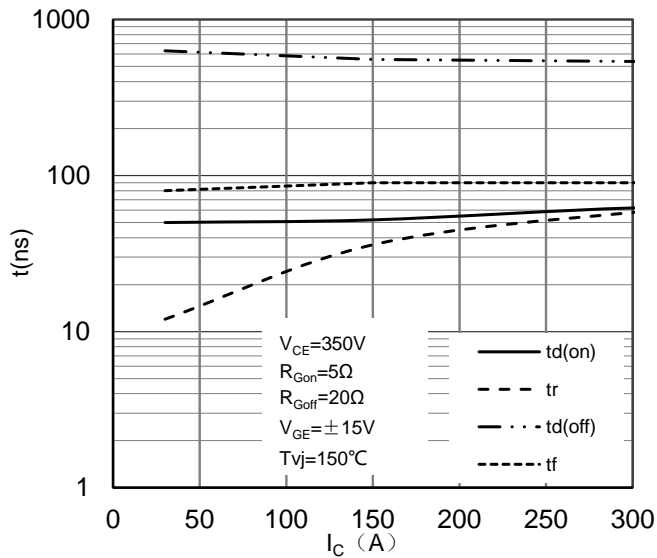


Figure 9. Switching Times vs Collector Current IGBT (T11, T12, T13, T14)

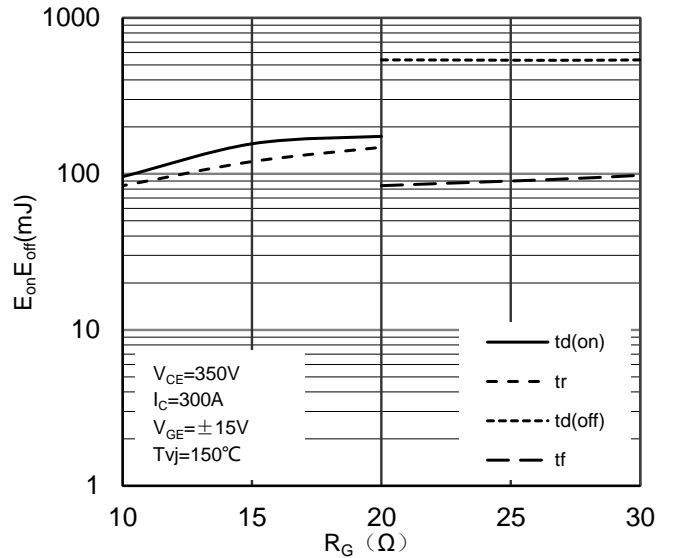


Figure 10. Switching Times vs Gate Resistor IGBT (T11, T12, T13, T14)

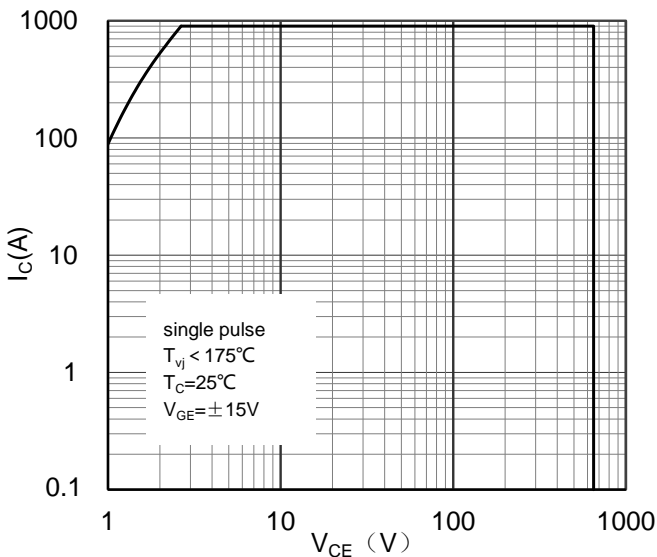


Figure 11. Forward Biased Safe Operating Area (T11, T12, T13, T14)

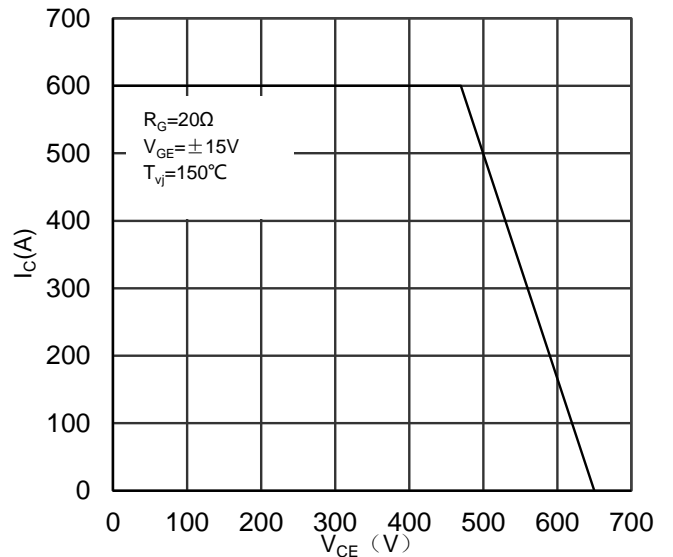


Figure 12. Reverse Biased Safe Operating Area IGBT (T11, T12)

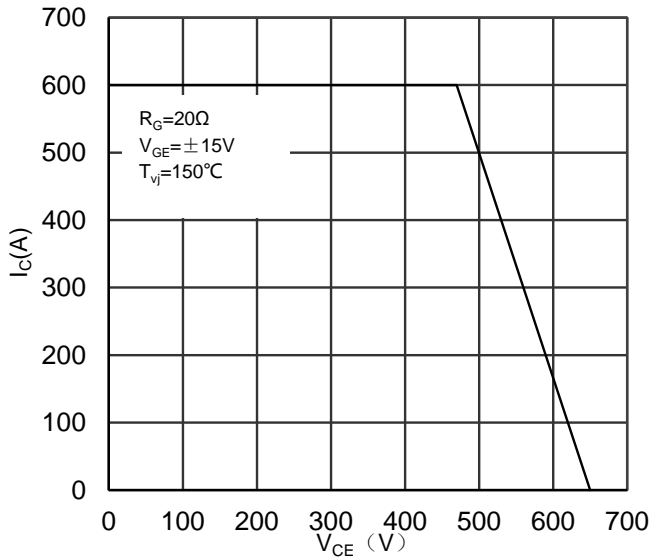


Figure 13. Reverse Biased Safe Operating Area IGBT (T13, T14)

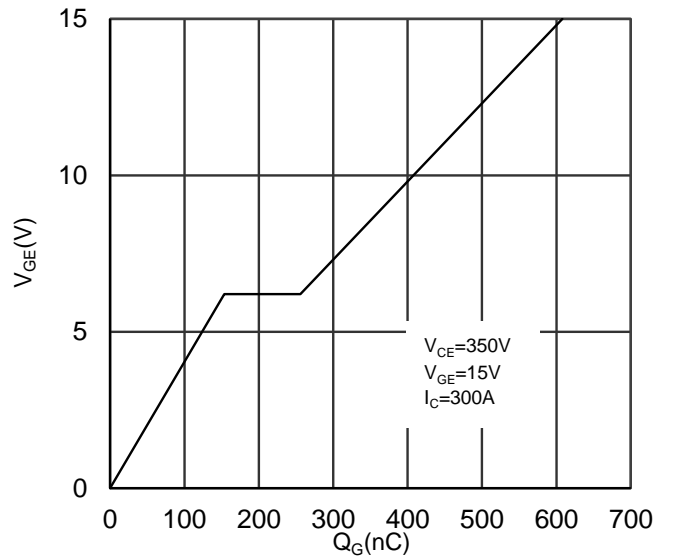


Figure 14. Typical Gate Charge (T11, T12, T13, T14)

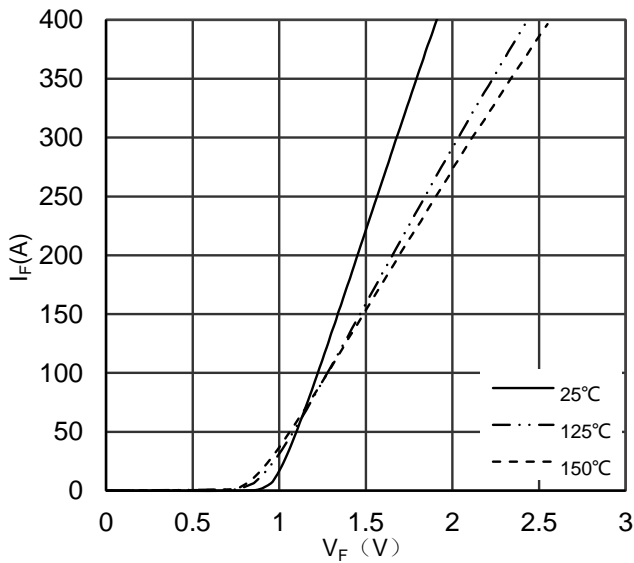


Figure 15. Diode Forward Characteristics Diode (D11, D12)

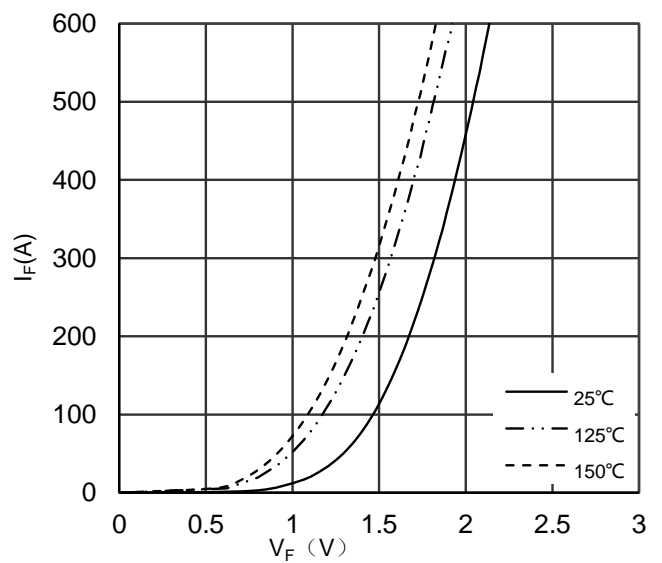


Figure 16. Diode Forward Characteristics Diode (D14, D15)

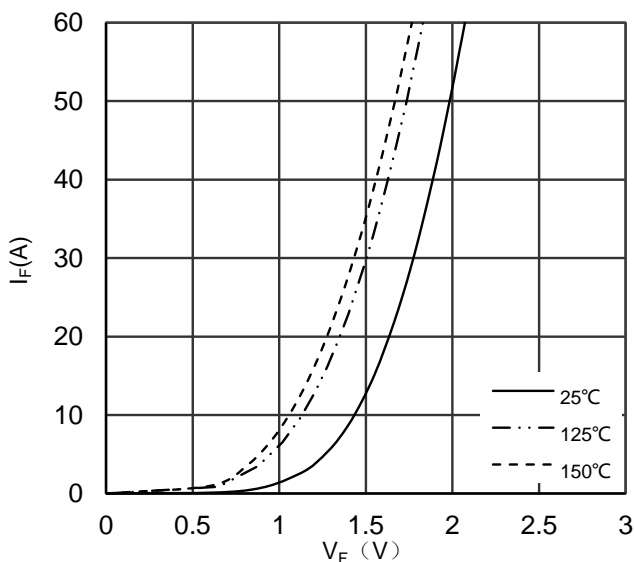


Figure 17. Diode Forward Characteristics Diode (D41, D42, D43, D44)

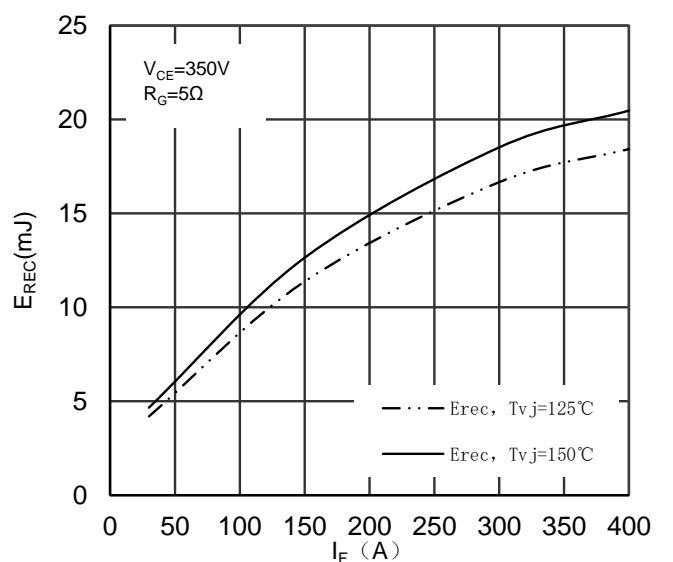


Figure 18. Switching Energy vs Forward Current Diode (D14, D15)

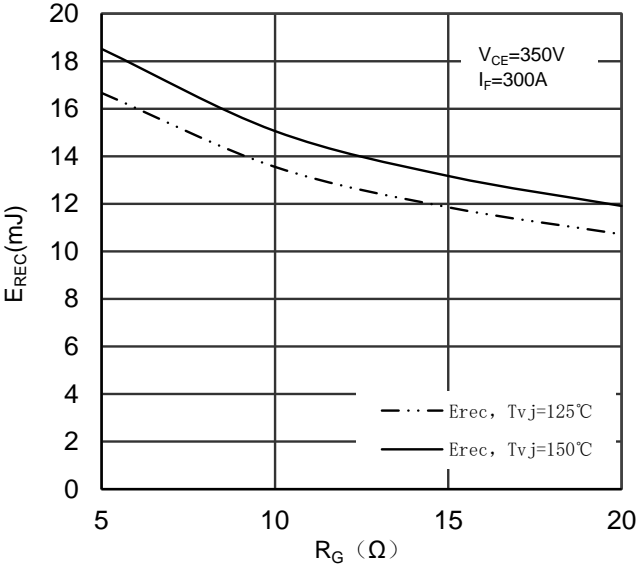


Figure 19. Switching Energy vs Gate Resistor Diode (D14, D15)

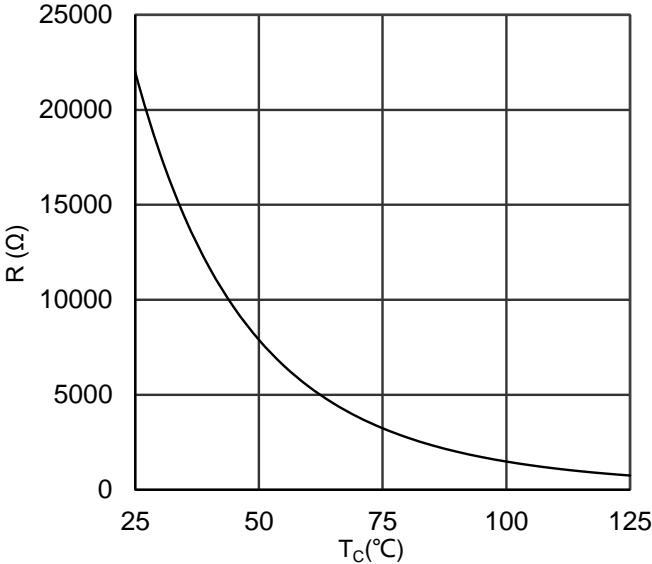
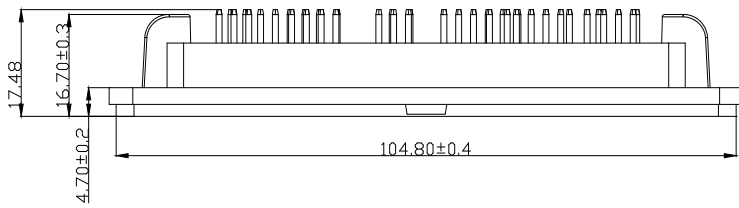
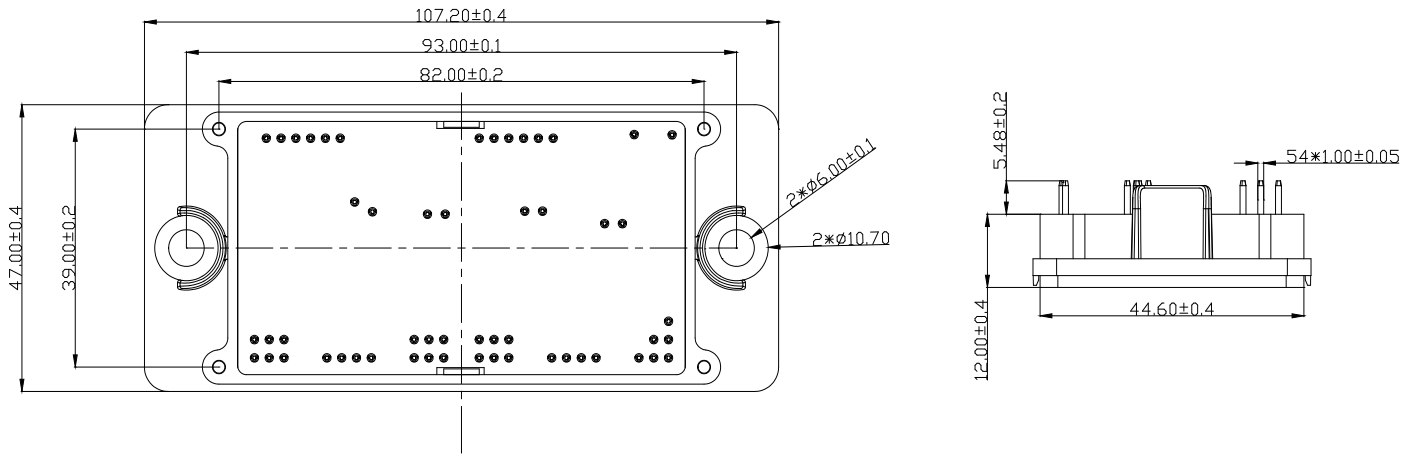


Figure 20. NTC Characteristics

MMG300HP065PG6T5



Dimensions in (mm)

Figure 22. Package Outline

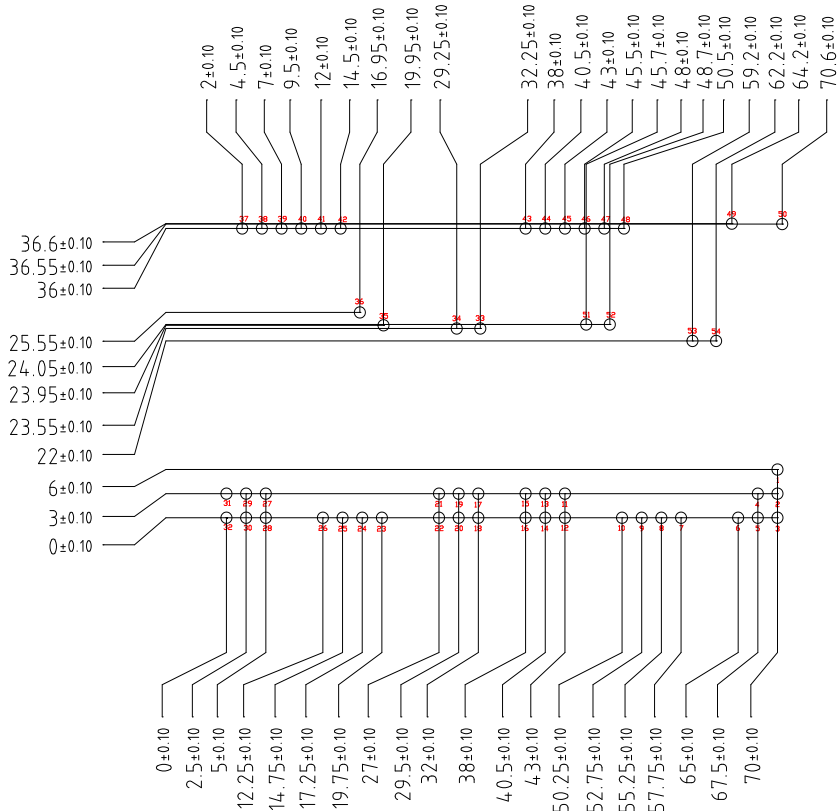


Figure 23. Pin Position (mm)